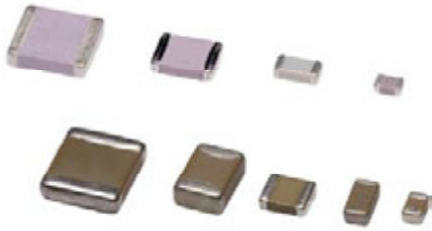


OP Series

Open Mode Chips Capacitors



FEATURES

- Case sizes: 0805 to 2220
- NPO and X7R dielectrics
- Capacitance range: 1pF to 4.7μF
- Designed to significantly minimize the probability of short circuit or low IR failure due to board flexion
- Ag/Pd/Pt, Ni barrier, epoxy terminations available
- RoHS and Non RoHS compliant capacitors available
- Screening in accordance with ESA specifications available

PHYSICAL CHARACTERISTICS

CONSTRUCTION

MLCC capacitors for surface mounting with optional Nickel barrier

MARKING (on request)

Capacitance value code

ELECTRICAL SPECIFICATIONS

Description	NPO	X7R
Operating temperature	-55°C to +125°C*	-55°C to +125°C*
Climatic category	55 / 125 / 56	55 / 125 / 56
Rated voltage (U_{RC})	10V _{DC} to 100V _{DC}	10V _{DC} to 100V _{DC}
Maximum ΔC/°C over temperature range without DC voltage applied	NA	±15%
Temperature coefficient with or without DC voltage applied	(0 ± 30)ppm/°C	NA
Dielectric withstanding voltage	2.5 U _{RC}	2.5 U _{RC}
Capacitance	at 1MHz for C ≤ 1,000pF at 1kHz for C > 1,000pF	at 1MHz for C ≤ 100pF at 1kHz for C > 100pF
Dissipation factor at 25°C	≤ 0.015 (150/C + 7)% at 1MHz for C ≤ 50pF ≤ 0.15% at 1MHz for 50pF < C ≤ 1,000pF ≤ 0.15% at 1kHz for C > 1,000pF	≤ 2.5% at 1MHz for C ≤ 100pF ≤ 2.5% at 1kHz for C > 100pF
Insulation resistance at 25°C under U_{RC}	≥ 100,000 MΩ for C ≤ 10nF ≥ 1,000 MΩ.μF for C > 10nF	≥ 100,000 MΩ for C ≤ 10nF ≥ 1,000 MΩ.μF for C > 10nF
Aging	None	≤ 2.5% per decade hour

Other temperature coefficients, temperature characteristics 2B1, BX, BR and Bismuth free dielectrics are available.

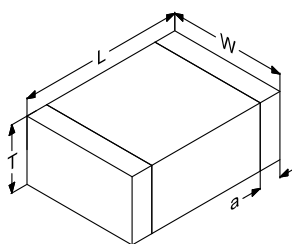
* Operating temperature up to 250°C available upon request. Contact your sales representative.

HOW TO ORDER

OP	1210	X7R	C	M	F	270nF	10%	50V	S8	T5		
Series	Size	Dielectric	Termination	Marking	Quality level	Capacitance	Tolerance	Rated voltage	Packaging	Reliability level		
OP: Open-mode	0805 1206 1210 1812 2220	NPO X7R	W = RoHS compliant		- = no marking M = Marking: capacitance value coded (from 0805 to 3040 sizes).	- = standard quality level F = Hi-Rel quality: screening in accordance with Exxelia specification	Capacitance value in clear	NPO: cap. value ≤ 12pF ± 0.25pF cap. value ≤ 8.2pF ± 0.5pF ± 1pF cap. value > 22pF ± 1% cap. value > 12pF ± 2% cap. value > 8.2pF ± 5% ± 10% cap. value > 3.9pF ± 20% X7R: ± 5% ± 10% ± 20%	10V 16V 25V 50V 100V Intermediary and higher voltages available on request.	- = Exxelia packaging S8* = available for 0402 to 1210 sizes. S12* = available for 1812 to 2220 sizes. BA* = available for 0402 to 2220 (except 0907) sizes. * not available with H, HW and E, EW terminations See page 13	For F parts only. Acc. to Exxelia spec. - T5 T6 See page 15	
			Ag/Pd/Pt	W								Ag/Pd/Pt
			Ag *	QW								Ag
			Ag + Ni + dipped Sn/Pb 60/40 **	-								-
			Ag/Pd/Pt + dipped Sn/Pb 60/40	HW								Ag/Pd/Pt + dipped Sn
			Ag + Ni + electrolytic Sn/Pb 95/5	CW								Ag + Ni + electrolytic Sn
			Ag + Ni + electrolytic Sn/Pb 60/40	-								-
			Ag + Ni + dipped Sn/Pb 60/40	EW								Ag + Ni + electrolytic Sn
			Ag + Ni + Au	GW								Ag + Ni + Au
			Ag + Polymer + Ni + Sn/Pb 95/5	YCW								Ag + Polymer + Ni + Sn
			Ag + Polymer + Ni + Sn/Pb 60/40	-								-
			Ag + Polymer + Ni + Au	YGW								Ag + Polymer + Ni + Au

* Only 1812 to 3040 sizes
** Maintenance only

DIMENSIONS in inches (mm)



L, W, T for tinned chips [E, EW, H, HW]: +0.02" (+0.5mm)

STANDARD RATINGS

Size	0805		1206		1210		1812		2220		
Dimensions inches (mm)	L	0.079 ± 0.012 [2 ± 0.3]	0.126 ± 0.01 [3.2 ± 0.25]	0.126 ± 0.016 [3.2 ± 0.4]	0.177 ± 0.02 [4.5 ± 0.5]	0.224 ± 0.02 [5.7 ± 0.5]					
	W	0.049 ± 0.008 [1.25 ± 0.2]	0.063 ± 0.006 [1.6 ± 0.15]	0.098 ± 0.012 [2.5 ± 0.3]	0.126 ± 0.016 [3.2 ± 0.4]	0.197 ± 0.02 [5 ± 0.5]					
	a	0.02 ± 0.012 [0.5 ± 0.3]	0.02 ± 0.012 [0.5 ± 0.3]	0.024 ± 0.016 [0.6 ± 0.4]	0.024 ± 0.016 [0.6 ± 0.4]	0.024 ± 0.016 [0.6 ± 0.4]					
	Tmax.	0.052 [1.3]	0.063 [1.6]	0.071 [1.8]	0.071 [1.8]	0.079 [2]					
Dielectric	NPO	X7R	NPO	X7R	NPO	X7R	NPO	X7R	NPO	X7R	
Min. Cap.value	1pF	10pF	1pF	100pF	10pF	180pF	47pF	470pF	100pF	1.2nF	
Rated voltage (U _{rated})	10V	5.6nF	270nF	18nF	820nF	27nF	1.5μF	47nF	2.7μF	120nF	4.7μF
	16V	5.6nF	220nF	18nF	680nF	27nF	1.2μF	47nF	2.2μF	120nF	3.9μF
	25V	3.3nF	120nF	10nF	330nF	15nF	560nF	27nF	1μF	56nF	2.2μF
	50V	1.8nF	68nF	4.7nF	150nF	6.8nF	330nF	12nF	680nF	27nF	1.5μF
	63V	1.5nF	39nF	3.9nF	82nF	5.6nF	180nF	10nF	390nF	22nF	820nF
	100V	820pF	18nF	1.8nF	47nF	2.7nF	100nF	5.6nF	180nF	12nF	470nF

Available capacitance values:

NPO: E6, E12, E24, E48, E96 (See page 14). Specific values upon request.

X7R: E6, E12, E24 (See page 14). Specific values upon request.

The above table defines the standard products, other components may be built upon request.

Other temperature coefficients, temperature characteristic 2B1 and Bismuth free dielectrics are available: contact your sales representative.

General Information NPO/COG (Class 1)

COMPOSITION

NPO capacitors are produced by using a dielectric made of titanium dioxide (TiO_2) modified by magnesium oxide MgO (white ceramics) or a rare earth oxide, e.g. Nd_2O_3 (other NPO ceramics).

As a consequence, these ceramics are non ferro-electric materials with a low dielectric constant ($\epsilon_r \leq 110$).

Other additives are used to dope the dielectric constant up to 300. Though derogating from CG class, doped dielectric constant features a linear temperature drift and a matchless stability compared with class 2 ceramics.

The wide range of possible NPO dielectric compositions enables to use the material best suited to the application :

- standard applications,
- high voltage,
- high temperature,
- microwave,
- power capacitors.

«Temperature coefficient» compositions are particularly suitable for impedance matching. These ceramics usually enable to achieve temperature coefficients from 0 to $-1000 \text{ ppm}/^\circ\text{C}$. For specific requirements, other coefficients can be achieved (e.g. $-3300 \text{ ppm}/^\circ\text{C}$).

STABILITY

As ϵ_r is low, these dielectrics are extremely stable with only minor changes under such stresses as :

- temperature,
- voltage,
- frequency.

In addition, they are not affected by piezo-electric phenomena and their dielectric absorption coefficients are low and even non measurable for dielectrics with the lowest constants.

MECHANICAL PROPERTIES

Class 1 ceramics are the perfect match for metallic electrodes made of Pd or Ag-Pd alloy and have a high hardness and mechanical toughness making them resistant to thermal shocks (wave soldering for instance) and to thermal cycling after mounting on substrates having an expansion coefficient close to the capacitor one.

Ceramic chips meet CECC 32100 and NF C 93133 standards.

CLIMATIC CATEGORIES

Climatic categories are identified by three-digit codes as per NF C 20700 standard. Coding method is described in table 6.

e.g. : $-55^\circ\text{C} + 125^\circ\text{C} / 56$ days category is identified by code 434.

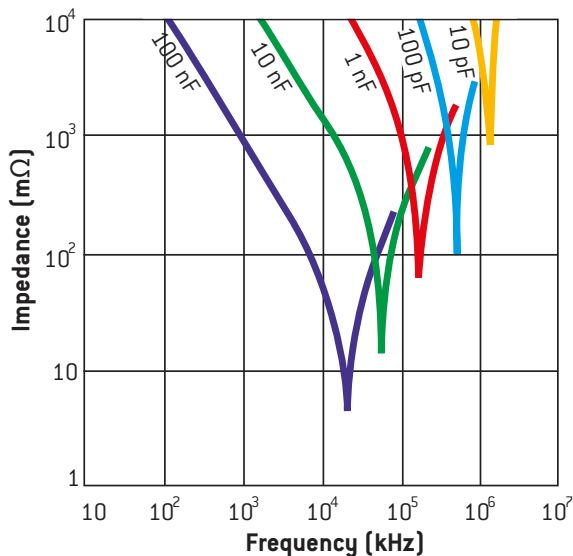
TEMPERATURE COEFFICIENT

Temperature coefficient $k\theta$ (ppm/ $^\circ\text{C}$)		
$k\theta$	Tolerances	Code letter
+ 100	± 30	AG
0	± 30	CG
- 33	± 30	HG
- 75	± 30	LG
- 150	± 30	PG
- 220	± 30	RG
- 330	± 60	SH
- 470	± 60	TH
- 750	± 120	UJ
- 1 000	± 250	QK

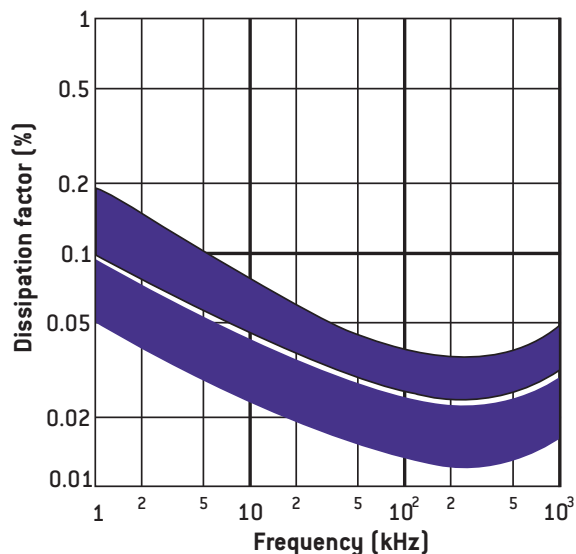
General Information NPO/COG (Class 1)

STANDARD

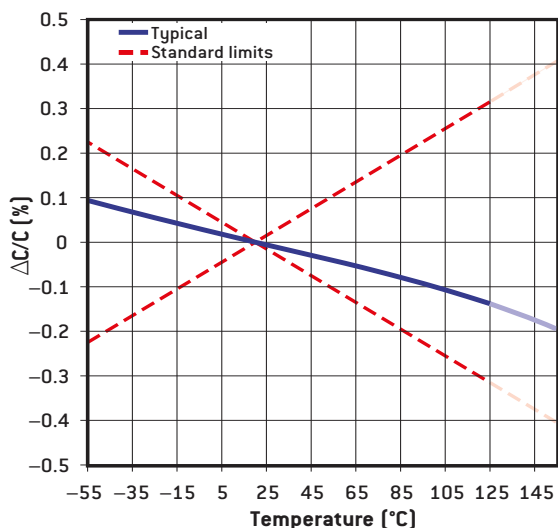
IMPEDANCE VERSUS FREQUENCY



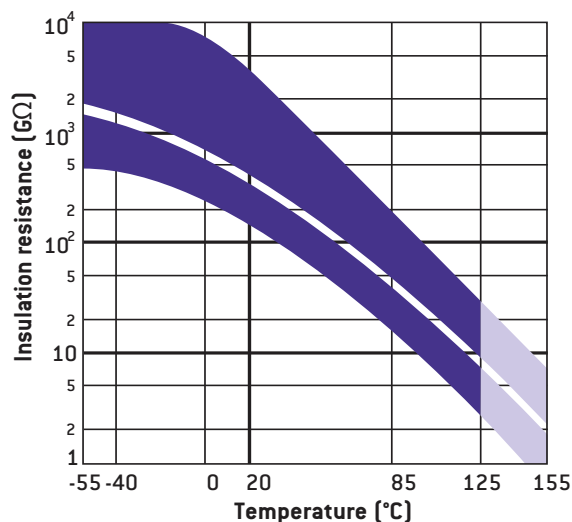
DISSIPATION FACTOR VERSUS FREQUENCY



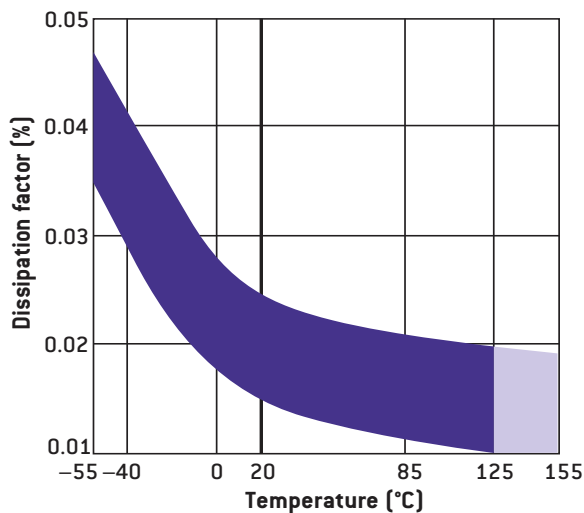
CAPACITANCE CHANGE VERSUS TEMPERATURE



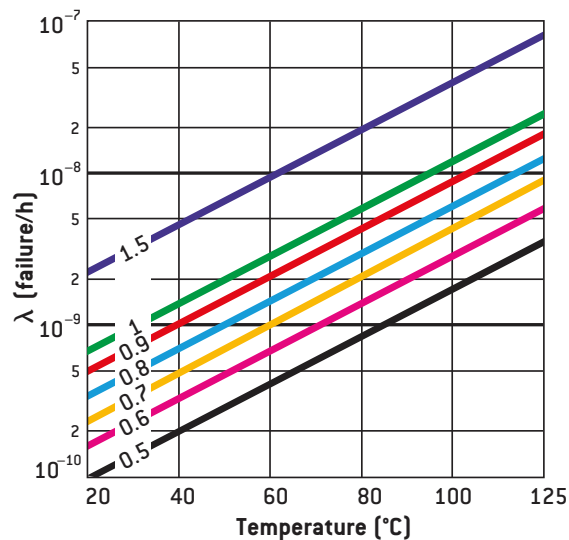
IR VERSUS TEMPERATURE



DISSIPATION FACTOR VERSUS TEMPERATURE



TYPICAL FAILURE RATE VERSUS TEMPERATURE



General Information X7R (Class 2)

COMPOSITION

Class 2 capacitors are produced by using a dielectric made of barium titanate (Ba Ti O₃). By nature, the dielectric is a ferroelectric compound with a high dielectric constant usually varying :

- from 1000 to 5000 - typical of capacitors meeting 2C1 type specifications (BX, X7R),
- from 5000 to 15000 - typical of capacitors meeting Z5U or Y5V type specifications.

Depending on whether the dielectric contains a flux additive, mainly bismuth or boron, electrodes are made of Ag-Pd alloys with high silver content or high palladium content, even pure palladium in some cases.

STABILITY

As the dielectric is a ferro-electric material, class 2 capacitors present significant variations under such stresses as :

- temperature,
- voltage,
- frequency.

In addition, the dielectric absorption coefficient can reach a few % and piezo-electric phenomena can affect the dielectric at critical frequencies (full information and specific documents available on request).

MECHANICAL PROPERTIES

Class 2 dielectrics are hard materials and are sensitive to thermo-mechanical stress. Stress should be limited when mounting and adequate substrates with an adapted expansion coefficient used.

BISMUTH OR BISMUTH FREE DIELECTRICS

Class 2 capacitors are made of ceramics capable to embed a flux element (e.g. bismuth or boron salt). Their eventual use will affect the choice of electrode alloys firing temperature used. Capacitor behavior under such constraints as temperature, voltage, frequency and even reliability, in some applications (further information available on request), is also different.

That is why French and European standard authorities have decided to differentiate bismuth from bismuth free ceramics by measuring tangent δ at -55°C . Tangent $\text{Tg } \delta$ (-55°C) 350.10^{-4} in flux free dielectrics.

Flux free dielectrics are identified by suffix «A» after capacitor type (e.g. CNC2A).

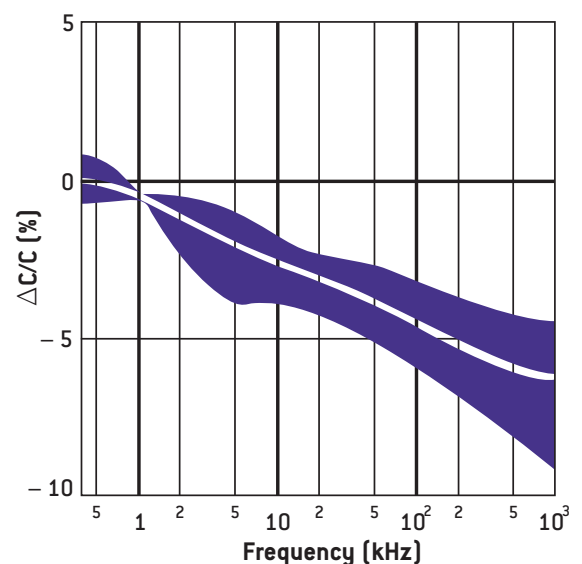
CAPACITANCE/TEMPERATURE RELATIONSHIP

Capacitance variations are defined within a specified temperature range, +20°C being the reference temperature. This characteristic is expressed by associating the temperature range and capacitance stability.

Stability category Code letter	Max. capacitance variation (%) with reference to capacitance at 20°C	
	Without voltage	At rated DC voltage (U _{DC})
B	± 10	+ 10– 15
C	± 20	+ 20– 30
D	+ 20– 30	+ 20– 40
E	+ 20– 55	+ 20– 65
R	+ 15– 15	Not applicable
X	+ 15– 15	+ 15– 25

Temperature category	
Code	Temperature range
1	– 55°C + 125°C
2	– 55°C + 85°C
4	– 25°C + 85°C

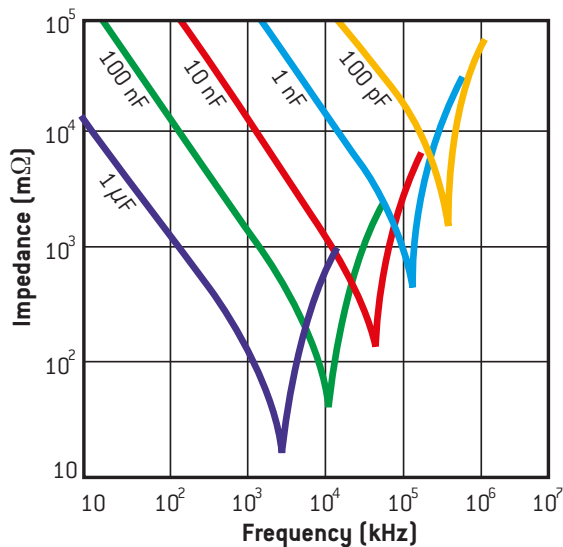
CAPACITANCE CHANGE VERSUS FREQUENCY



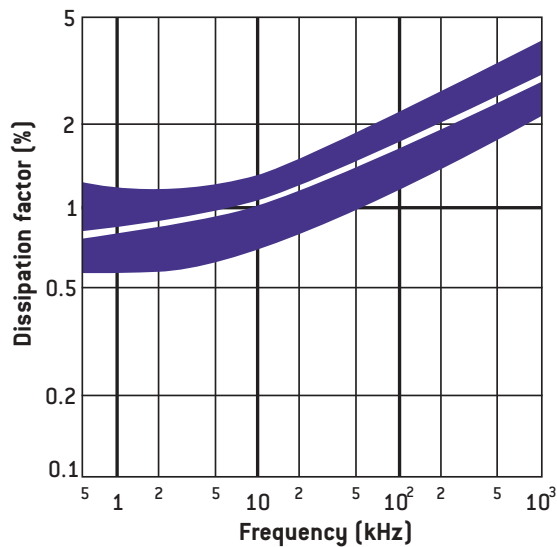
General Information X7R (Class 2)

STANDARD

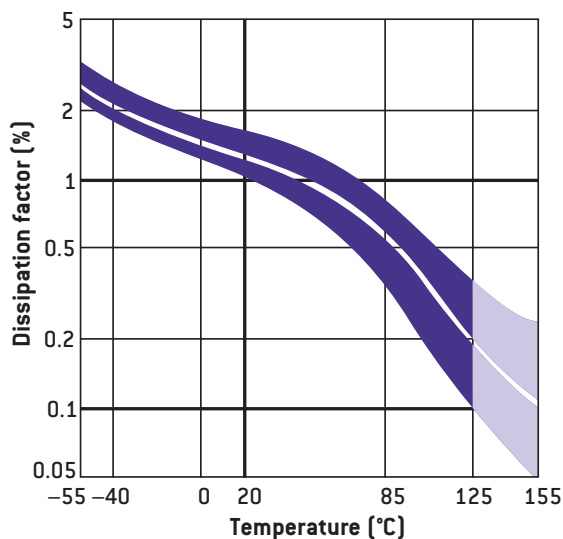
IMPEDANCE VERSUS FREQUENCY



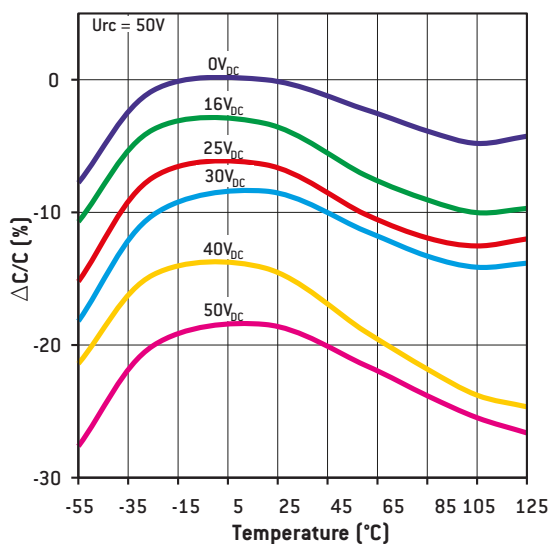
DISSIPATION FACTOR VERSUS FREQUENCY



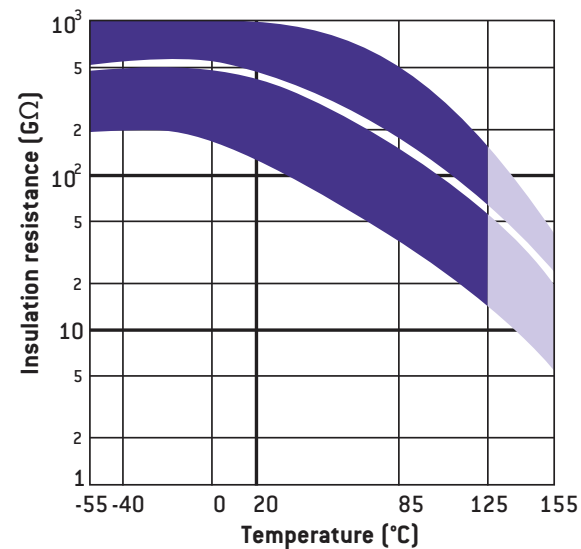
DISSIPATION FACTOR VERSUS TEMPERATURE



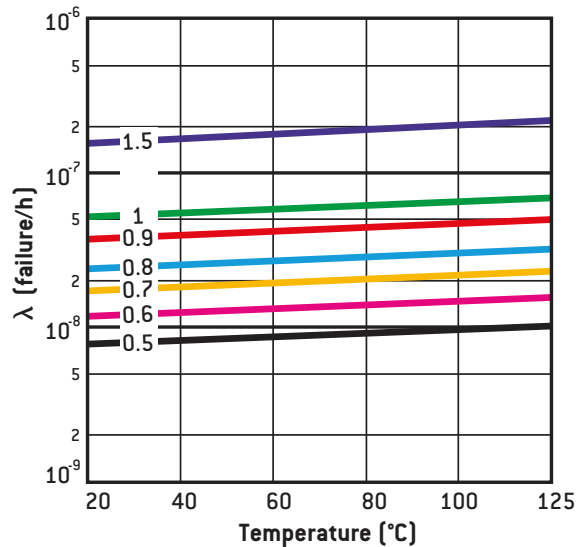
CAPACITANCE CHANGE VERSUS TEMPERATURE



IR VERSUS TEMPERATURE

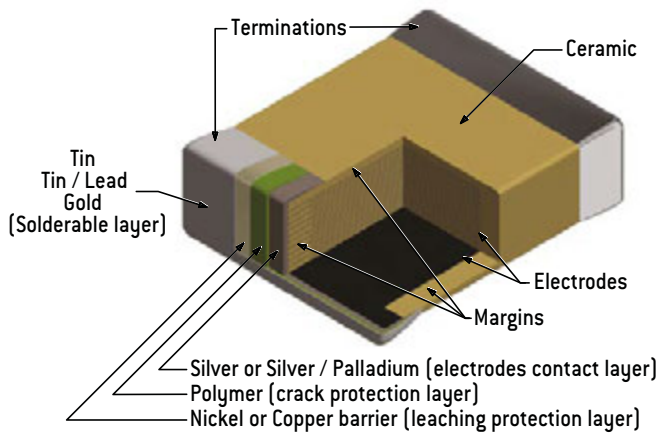


TYPICAL FAILURE RATE VERSUS TEMPERATURE



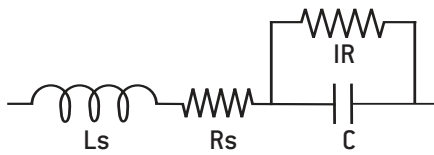
Ceramic Capacitors Technology

MLCC STRUCTURE



EQUIVALENT CIRCUIT

Capacitor is a complex component combining resistive, inductive and capacitive phenomena. A simplified schematic for the equivalent circuit is:



DIELECTRIC CHARACTERISTICS

Insulation Resistance (IR) is the resistance measured under DC voltage across the terminals of the capacitor and consists principally of the parallel resistance shown in the equivalent circuit. As capacitance values and hence the area of dielectric increases, the IR decreases and hence the product (C x IR) is often specified in $\Omega \cdot F$ or $M\Omega \cdot \mu F$.

The Equivalent Series Resistance (ESR) is the sum of the resistive terms which generate heating when capacitor is used under AC voltage at a given frequency (f).

Dissipation factor (DF) is the ration of the apparent power input will turn to heat in the capacitor:

$$DF = 2\pi f C ESR$$

When a capacitor works under AC voltage, **heat power loss (P)**, expressed in Watt, is equal to:

$$P = 2\pi f C V_{rms}^2 DF$$

The series inductance (Ls) is due to the currents running through the electrodes. It can distort the operation of the capacitor at high frequency where the **impedance (Z)** is given as:

$$Z = R_s + j (L_s \cdot \omega - 1 / (C \cdot \omega)) \text{ with } \omega = 2\pi f$$

When frequency rises, the capacitive component of capacitors is gradually canceled up to the resonance frequency, where :

$$Z = R_s \text{ and } L_s C \cdot \omega^2 = 1$$

Above this frequency the capacitor behaves like an inductor.

	P100	NPO	N2200 (C4xx)	BX	2C1	X7R
Dielectric material	Porcelain	Magnesium titanate or Neodymium baryum titanate	Barium zirconate titanate	Baryum titanate (BaTiO ₃)		
Dielectric constant	15 – 18	20 – 85	450	2,000 – 5,000		
Electrode technology	PME (Precious Metal Electrodes): Ag/Pd					
Capacitance variation between —55°C and +125°C without DC voltage	[100 ± 30]ppm/°C	[0 ± 30]ppm/°C	[–2,200 ± 500] ppm/°C	± 15%	± 20%	± 15%
Capacitance variation between —55°C and +125°C with DC rated voltage			0 -15%	15% –25%	20% –30%	Not applicable
Piezo-electric effect	None		None	Yes		
Dielectric absorption	None		Few %	Few %		
Thermal shock sensitive	+		+	++		

Ceramic Capacitors Technology

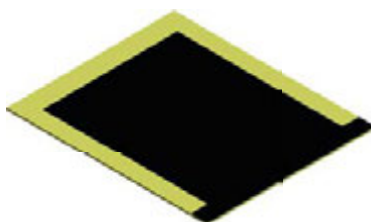
MANUFACTURING STEPS

SLIP CASTING



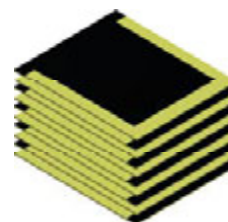
A slurry, a mix of ceramic powder, binder and solvents, is poured onto conveyor belt inside a drying oven, resulting in a dry ceramic sheet.

ELECTRODE SCREEN PRINTING



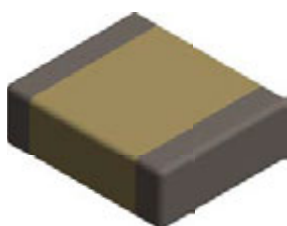
The electrode ink, made from a metal powder mixed with solvents, is printed onto the ceramic sheets using a screen printing process.

STACKING



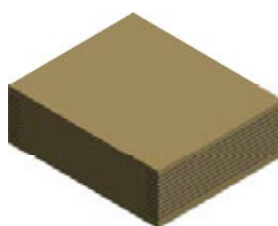
The sheets with electrode printed are stacked to create a multilayer structure.

TERMINATIONS



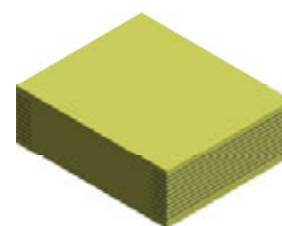
Each terminal of the capacitor is dipped in the termination ink, mix of metal powder, solvents and glass frit and the parts are fired in an oven.

SINTERING



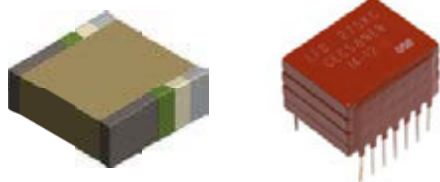
The parts are sintered in an oven with a precise temperature profile which is very important to the characteristics of the capacitors.

PRESSING



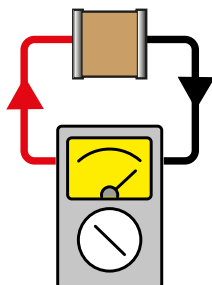
Pressure is applied to the stack to fuse all the separate layers, this created a monolithic structure.

TERMINATIONS PLATING



Stacking + leads soldering + encapsulation
[see pages 10-11]

FINAL TESTING



PACKAGING



User Guide

SMD TERMINATIONS

NON RoHS COMPLIANT	Code	RoHS COMPLIANT	Code	Recommended mounting process							Storage [months]*	
				Magnetic	Epoxy bonding	Iron soldering	Wave soldering	Vapor phase soldering	Infrared soldering	Wire bonding		
Ag	Q	Ag	QW / P	No	•	•	•	•				18
Ag/Pd/Pt	-	Ag/Pd/Pt	W / A	No	•	•	•					24
Ag + Ni + dipped Sn/Pb 60/40	T**	-	-	No		•	•	•	•			24
Ag/Pd/Pt + dipped Sn/Pb 60/40	H	Ag/Pd/Pt + dipped Sn	HW	No		•						24
Ag + Ni + electrolytic Sn/Pb 95/5	C	Ag + Ni + electrolytic Sn	CW / S	Yes		•	•	•	•			18
Ag + Ni + electrolytic Sn/Pb 60/40	D	-	-	Yes		•	•	•	•			18
-	-	Ag + Cu + electrolytic Sn	C***	No		•	•	•	•			18
Ag + Ni + dipped Sn/Pb 60/40	E	Ag + Ni + electrolytic Sn	EW	Yes		•	•					24
Ag + Ni + Au	G	Ag + Ni + Au	GW	Yes	•	•	•	•	•	•		36
Ag + Polymer + Ni + Sn/Pb 95/5	YC	Ag + Polymer + Ni + Sn	YCW	Yes		•	•	•	•			18
Ag + Polymer + Ni + Sn/Pb 60/40	YD	-	-	Yes		•	•	•	•			18
Ag + Polymer + Ni + Au	YG	Ag + Polymer + Ni + Au	YGW	Yes	•	•	•	•	•	•		36

Nickel (Ni) or Copper (Cu) barriers amplify thermal shock and are not recommended for chip sizes larger than 3030.

* Storage must be in a dry environment at a temperature of 20° C with a relative humidity below 50%, or preferably in a package enclosing a desiccant.

** Maintenance only.

*** Non magnetic chips series only.

SMD ENVIRONMENTAL TESTS

Ceramic chip capacitors for SMD are designed to meet test requirements of **CECC 32100** and **NF C 93133** standards as specified below in compliance with NF C 20700 and IEC 68 standards:

- Solderability: **NF C 20758**, 260° C, bath 62/36/2.
- Adherence: 5N force.
- Vibration fatigue test: **NF C 20706**, 20 g, 10 Hz to 2,000 Hz, 12 cycles of 20 minutes each.
- Rapid temperature change: **NF C 20714**, –55°C to + 125° C, 5 cycles.
- Combined climatic test: **IEC 68-2-38**.
- Damp heat: **NF C 20703**, 93 %, H.R., 40° C.
- Endurance test: 1,000 hours, 1.5 U_{RC}, 125° C.

STORAGE OF CHIP CAPACITORS

TINNED OR NON TINNED CHIP CAPACITORS

Storage must be in a dry environment at a temperature of 20°C with a relative humidity below 50 %, or preferably in a packaging enclosing a desiccant.

STORAGE IN INDUSTRIAL ENVIRONMENT:

- 2 years for tin dipped chip capacitors,
- 18 months for tin electroplated chip capacitors,
- 2 years for non tinned chip capacitors,
- 3 years for gold plated chip capacitors.

STORAGE IN CONTROLLED NEUTRAL NITROGEN ENVIRONMENT:

- 4 years for tin dipped or electroplated chip capacitors,
- 4 years for non tinned chip capacitors,
- 5 years for gold plated chip capacitors.

Storage duration should be considered from delivery date and not from batch manufacture date. The tests carried out at final acceptance stage [solderability, susceptibility to solder heat] enable to assess the compatibility to surface mounting of the chips.

User Guide

LEAD STYLES

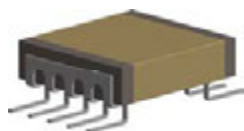
SURFACE MOUNTING

DIL LEADS

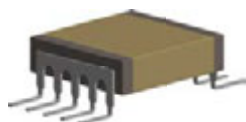
P style



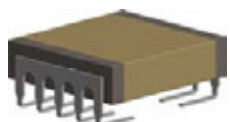
PL style



L style

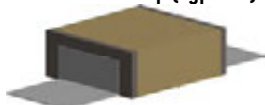


J style

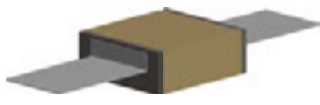


RIBBON LEADS

Micro-strip (type 1)
Short Micro-strip (type 1S)



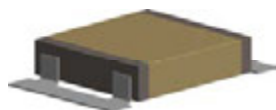
Axial (Type 2)



Radial (Type 3)



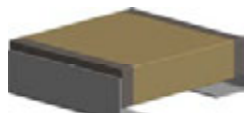
R style



RX style



RJ style



Please contact Exxelia sales for any lead configuration not shown.

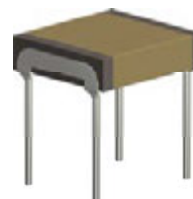
TROUGH-HOLE MOUNTING

AXIAL AND RADIAL

Radial leads (Type 6)



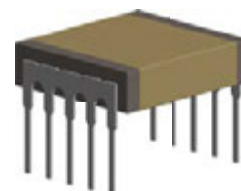
Radial leads (4 leads)



Axial leads (Type 7)



DIL leads: N style

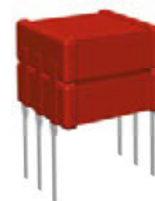


ENCAPSULATION STYLES

Ceramic encapsulation
(selfprotected)



Varnish



Conformal coating

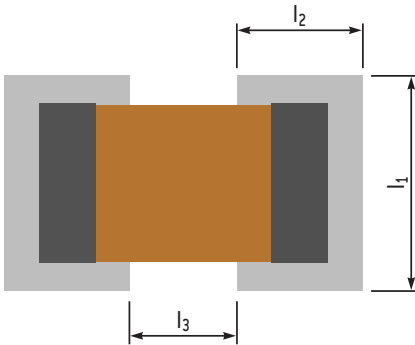


Molding



User Guide

SOLDERING ADVICES FOR REFLOW SOLDERING



Large chips above size 2225 are not recommended to be mounted on epoxy board due to thermal expansion coefficient mismatch between ceramic capacitor and epoxy. Where larger sizes are required, it is recommended to use components with ribbon or other adapted leads so as to absorb thermo-mechanical strains.

Dimensions in inches (in mm)	Reflow soldering						Wave soldering					
	l_1		l_2		l_3		l_1		l_2		l_3	
0402	0.043	[1.1]	0.035	[0.9]	0.012	[0.3]	0.043	[1.1]	0.047	[1.2]	0.012	[0.3]
0403	0.055	[1.4]	0.035	[0.9]	0.012	[0.3]	0.055	[1.4]	0.047	[1.2]	0.012	[0.3]
0504	0.063	[1.6]	0.051	[1.3]	0.016	[0.4]	0.063	[1.6]	0.063	[1.6]	0.016	[0.4]
0603	0.055	[1.4]	0.059	[1.5]	0.02	[0.5]	0.055	[1.4]	0.071	[1.8]	0.02	[0.5]
0805	0.073	[1.85]	0.065	[1.65]	0.024	[0.6]	0.073	[1.85]	0.077	[1.95]	0.024	[0.6]
0907	0.094	[2.4]	0.065	[1.65]	0.035	[0.9]	0.094	[2.4]	0.077	[1.95]	0.035	[0.9]
1005	0.073	[1.85]	0.067	[1.7]	0.039	[1]	0.073	[1.85]	0.079	[2]	0.039	[1]
1206	0.083	[2.1]	0.067	[1.7]	0.059	[1.5]	0.083	[2.1]	0.079	[2]	0.059	[1.5]
1210	0.118	[3]	0.069	[1.75]	0.059	[1.5]	0.118	[3]	0.081	[2.05]	0.059	[1.5]
1605	0.073	[1.85]	0.071	[1.8]	0.087	[2.2]	0.073	[1.85]	0.083	[2.1]	0.087	[2.2]
1806	0.087	[2.2]	0.073	[1.85]	0.102	[2.6]	0.087	[2.2]	0.085	[2.15]	0.102	[2.6]
1812	0.152	[3.85]	0.073	[1.85]	0.102	[2.6]	0.152	[3.85]	0.085	[2.15]	0.102	[2.6]
1825	0.281	[7.15]	0.073	[1.85]	0.102	[2.6]	0.281	[7.15]	0.085	[2.15]	0.102	[2.6]
2210	0.13	[3.3]	0.079	[2]	0.146	[3.7]	0.13	[3.3]	0.091	[2.3]	0.146	[3.7]
2220	0.228	[5.8]	0.079	[2]	0.146	[3.7]	0.228	[5.8]	0.091	[2.3]	0.146	[3.7]
2225	0.281	[7.15]	0.079	[2]	0.146	[3.7]	0.281	[7.15]	0.091	[2.3]	0.146	[3.7]

RECOMMENDED FOOTPRINT FOR SMD CAPACITORS

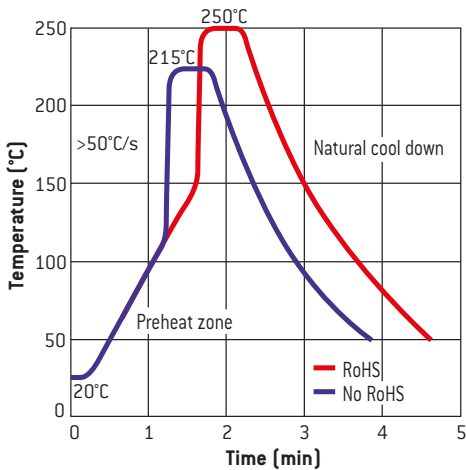
Ceramic is by nature a material which is sensitive both thermally and mechanically. Stresses caused by the physical and thermal properties of the capacitors, substrates and solders are attenuated by the leads.

Wave soldering is unsuitable for sizes larger than 2220 and for the higher ends of capacitance ranges due to possible thermal shock (capacitance values given upon request).

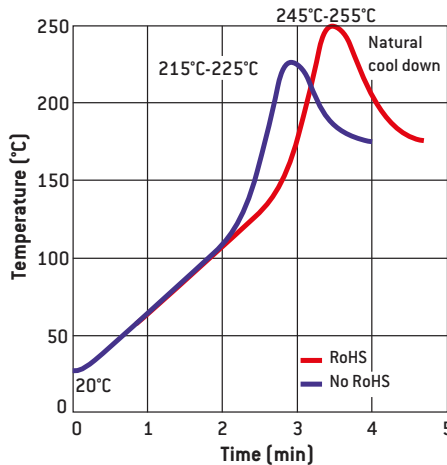
Infrared and vapor phase reflow, are preferred for high reliability applications as inherent thermo-mechanical strains are lower than those inherent to wave soldering.

Whatever the soldering process is, it is highly recommended to apply a thermal cycle, see hereafter our recommended soldering profile:

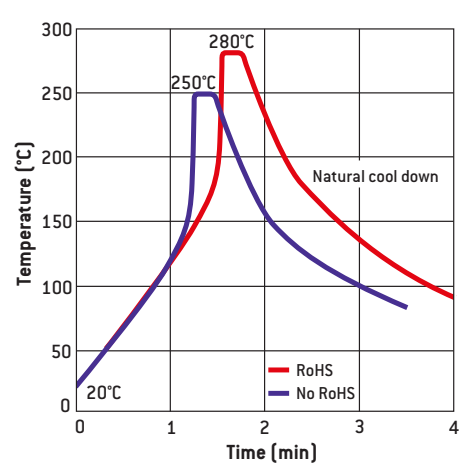
RECOMMENDED VAPOR PHASE REFLOW PROFILE



RECOMMENDED IR REFLOW PROFILE



RECOMMENDED WAVE SOLDERING PROFILE



User Guide

SOLDERING ADVICES FOR IRON SOLDERING

Attachment with a soldering iron is discouraged due to ceramic brittleness and the process control limitations. In the event that a soldering iron must be used, the following precautions should be observed:

- Use a substrate with chip footprints big enough to allow putting side by side one end of the capacitor and the iron tip without any contact between this tip and the component,
- place the capacitor on this footprint,
- heat the substrate until the capacitor's temperature reaches 150° C minimum [preheating step, maximum 1°C per second],
- place the hot iron tip [a flat tip is preferred] on the footprint **without touching the capacitor**. Use a regulated iron with a 30 watts maximum power. The recommended temperature of the iron is 270 ± 10° C. The temperature gap between the capacitor and the iron tip must not exceed 120° C,

- leave the tip on the footprint for a few seconds in order to increase locally the footprint's temperature,
- use a cored wire solder and put it down on the iron tip. In a preferred way use Sn/Pb/Ag 62/36/2 alloy,
- wait until the solder fillet is formed on the capacitor's termination,
- take away iron and wire solder,
- wait a few minutes so that the substrate and capacitor come back down to the preheating temperature,
- solder the second termination using the same procedure as the first,
- let the soldered component cool down slowly to avoid any thermal shock.

PACKAGING

TAPE AND REEL

The films used on the reels correspond to standard IEC 60286-3. Films are delivered on reels in compliance with document IEC 286-3 dated 1991.

Minimum quantity is 250 chips.

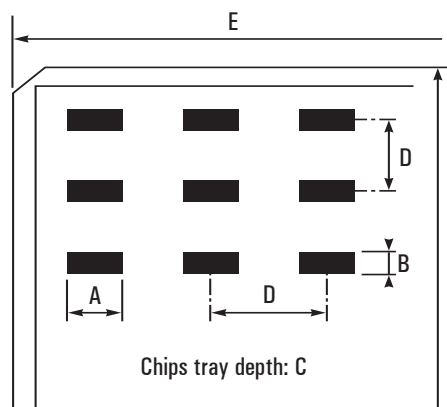
Maximum quantities per reel are as follows:

- Super 8 reel - Ø 180: 2,500 chips.
- Super 8 reel - Ø 330: 10,000 chips.
- Super 12 reel - Ø 180: 1,000 chips.

Reel marking complies with CECC 32100 standard:

- Model.
- Rated capacitance.
- Capacitance tolerance.
- Rated voltage.
- Batch number.

TRAY PACKAGES



DIMENSIONAL CHARACTERISTICS OF CHIPS TRAY PACKAGES

Sizes	Nr. of chips/ package	Oriented chips	Dimensions in inches (in mm)				
			A	B	C	D	E
0402	100	No	0 0.112 (0 3.02)		0.065 (1.65)	0.167 (4.24)	2 (50.8)
0403	100	No	0 0.112 (0 3.02)		0.065 (1.65)	0.167 (4.24)	2 (50.8)
0504	100	Yes	0.059 (1.5)	0.045 (1.14)	0.035 (0.89)	0.167 (4.24)	2 (50.8)
0603	340	Yes	0.1 (2.54)	0.06 (1.52)	0.045 (1.14)	0.167 (4.24)	2 (50.8)
0805	100	Yes	0.1 (2.54)	0.06 (1.52)	0.045 (1.14)	0.167 (4.24)	2 (50.8)
1206	100	No	0.14 (3.56)	0.14 (3.56)	0.06 (1.52)	0.167 (4.24)	2 (50.8)
1210	100	Yes	0.14 (3.56)	0.14 (3.56)	0.06 (1.52)	0.167 (4.24)	2 (50.8)
1812	100	No	0.25 (6.35)	0.25 (6.35)	0.13 (3.3)	0.345 (8.76)	4 (101.6)
	25	Yes	0.24 (6.1)	0.265 (6.73)	0.07 (1.78)	0.345 (8.76)	2 (50.8)
2220	100	Yes	0.25 (6.35)	0.25 (6.35)	0.13 (3.3)	0.345 (8.76)	4 (101.6)
	25	Yes	0.24 (6.1)	0.265 (6.73)	0.07 (1.78)	0.345 (8.76)	2 (50.8)

User Guide

EIA STANDARD CAPACITANCE VALUES

Following EIA standard, the values and multiples that are indicated in the chart below can be ordered. E48, E96 series and intermediary values are available upon request.

E6 (± 20%)	E12 (± 10%)	E24 (± 5%)
10	10	10
		11
		12
15	12	13
		15
		16
22	15	18
		20
		22
33	18	24
		27
		30
47	22	33
		36
		39
68	27	43
		47
		51
100	33	56
		62
		68
150	39	75
		82
		91

EIA CAPACITANCE CODE

The capacitance is expressed in three digit codes and in units of pico Farads (pF). The first and second digits are significant figures of the capacitance value and the third digit identifies the multiplier.

For capacitance value < 10pF, R designates a decimal point.
See examples below:

EIA code	Capacitance value		
	in pF	in nF	in μ F
2R2	2.2	0.0022	0.0000022
6R8	6.8	0.0068	0.0000068
220	22	0.022	0.000022
470	47	0.047	0.000047
181	180	0.18	0.00018
221	220	0.22	0.00022
102	1,000	1	0.001
272	2,700	2.7	0.0027
123	12,000	12	0.012
683	68,000	68	0.068
124	120,000	120	0.12
564	560,000	560	0.56
335	3,300,000	3,300	3.3
825	8,200,000	8,200	8.2
156	15,000,000	15,000	15
686	68,000,000	68,000	68
107	100,000,000	100,000	100
227	220,000,000	220,000	220

PART MARKING VOLTAGE CODES

Use the following voltage code chart for part markings:

Voltage (V)	Code	Letter code
25	250	A
40	400	B
50	500	C
63	630	D
100	101	E
200	201	G
250	251	H
400	401	K
500	501	L
1,000	102	M
2,000	202	P
3,000	302	R
4,000	402	S
5,000	502	T
7,500	752	U
10,000	103	W

PART MARKING TOLERANCE CODES

Use the following tolerance code chart for part markings:

Tolerance	Letter code
± 0.25pF	CU
± 0.5pF	DU
± 1pF	FU
± 1%	F
± 2%	G
± 5%	J
± 10%	K
± 20%	M

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RELIABILITY LEVELS

Exxelia proposes different reliability levels for the ceramic capacitors for both NPO and X7R ceramics.

